



Search Notes 	Application/Control No. 10626300	Applicant(s)/Patent Under Reexamination RICHIE ET AL.
	Examiner Kitov, Zeev	Art Unit 2836


Notes	Date	Examiner
Text search in all classes	02/13/2006	
Cross reference search	02/13/2006	ZK
Updated search	06/29/2006	ZK
Obtained translation of japanese documents	09/19/2006	ZK
Updated search	09/19/2006	ZK
U.S. Patent and Trademark Office		Part of Paper No.:



<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10626300</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>RICHIE ET AL.</p>
	<p>Examiner</p> <p>Kitov, Zeev</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
361	213	09/20/2006	ZK
	229	09/20/2006	ZK
	235	09/20/2006	ZK

U.S. Patent and Trademark Office	Part of Paper No.:
----------------------------------	--------------------

<i>Interference Searched</i> 	Application/Control No. 10626300	Applicant(s)/Patent Under Reexamination RICHIE ET AL.
	Examiner Kitov, Zeev	Art Unit 2836

Class	SubClass	Date	Examiner
-------	----------	------	----------

SEE ATTACHED

U.S. Patent and Trademark Office	Part of Paper No.:
----------------------------------	--------------------